FAIRCHILD

SEMICONDUCTOR®

FDD5N53/FDU5N53 N-Channel MOSFET 530V, 4A, 1.5Ω

Features

- $R_{DS(on)} = 1.25\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 2A$
- Low gate charge (Typ. 11nC)
- Low C_{rss} (Typ. 5pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant



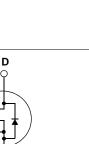
January 2009 UniFET[™]

tm

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pluse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power suppliesand active power factor correction.









Symbol	Parameter			FDD5N53/FDU5N53	Units
V _{DSS}	Drain to Source Voltage	530	V		
V _{GSS}	Gate to Source Voltage			±30	V
I _D	Drain Current	-Continuous (T _C = 25 ^o C)		4	
		-Continuous (T _C = 100 ^o C)		2.4	— A
I _{DM}	Drain Current	- Pulsed (Note 1)		16	А
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	256	mJ
I _{AR}	Avalanche Current		(Note 1)	4	А
E _{AR}	Repetitive Avalanche Energy		(Note 1)	4	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns
P _D	David Diasia dia d	$(T_{\rm C} = 25^{\rm o}{\rm C})$		40	W
	Power Dissipation	- Derate above 25°C		0.3	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	1.4	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	110	C/VV

	Device Marking Device		Packag	je	Reel Size	Тар	e Width		Quantit	у
	FDD5N53 FDD5N53TM D-PAK		ζ	380mm		6mm		2500	-	
FDD5N53 FDD5N53TF D-PA		(380mm	1	6mm		2000			
FDU5N	153	FDU5N53TU	I-PAK		-		-		70	
Electrica	l Char	acteristics				I		H		
Symbol		Parameter		Test Conditions		Min.	Тур.	Max.	Units	
Off Charac	teristics	S								
BV _{DSS}	/ _{DSS} Drain to Source Breakdown Voltage		$I_D = 250 \mu A, V_{GS} = 0V, T_J = 25^{\circ}C$			530	-	-	V	
ΔBV _{DSS} ΔT,		akdown Voltage Temperature		$I_D = 250 \mu A$, Referenced to $25^{\circ}C$		-	0.6	-	V/ºC	
Ū	7			$V_{DS} = 530$	0V, V _{GS} = 0V		-	-	1	•
I _{DSS}	Zero Ga	ate Voltage Drain Curre	ent	$V_{DS} = 424V, T_{C} = 125^{\circ}C$			-	-	10	μA
IGSS	Gate to	te to Body Leakage Current		$V_{GS} = \pm 30$	$VV, V_{DS} = 0V$		-	-	±100	nA
On Charac	teristics	5								
V _{GS(th)}	Gate Th	reshold Voltage		$V_{GS} = V_{DS}, I_D = 250 \mu A$			3.0	-	5.0	V
R _{DS(on)}	Static D	rain to Source On Res	istance	$V_{GS} = 10^{2}$	V, I _D = 2A		-	1.25	1.5	Ω
Ĵfs	Forward	d Transconductance		$V_{DS} = 40V, I_D = 2A$ (Note 4)		-	4.3	-	S	
Dynamic C	haracte	ristics								
C _{iss}	Input Ca	Capacitance t Capacitance se Transfer Capacitance		V _{DS} = 25V, V _{GS} = 0V f = 1MHz		-	480	640	pF	
C _{oss}	Output 0					-	66	88	pF	
2 _{rss}	Reverse					-	5	8	pF	
Q _{g(tot)}	Total Ga	Gate Charge at 10V o Source Gate Charge		$V_{DS} = 400V, I_{D} = 5A$		-	11	15	nC	
Q _{gs}	Gate to					-	3	-	nC	
Q _{gd}	Gate to	Drain "Miller" Charge	rain "Miller" Charge		V _{GS} = 10V (Note 4, 5)		-	5	-	nC
Switching	Charact	teristics								
t _{d(on)}	Turn-On	Delay Time					-	13	36	ns
	Turn-On	-On Rise Time		V _{DD} = 250V, I _D = 5A		-	22	54	ns	
d(off)	Turn-Off	Delay Time		$R_{G} = 25\Omega$		-	28	66	ns	
f	Turn-Off	Fall Time		_		(Note 4, 5)	-	20	50	ns
Drain-Sour	rce Diod	le Characteristic	S							
s	Maximur	m Continuous Drain to	Source Diode	e Forward	Current		-	-	4	Α
SM	Maximum Pulsed Drain to Source Diode For		rce Diode For	rward Current			-	-	16	Α
V _{SD}	Drain to	rain to Source Diode Forward Voltage		$V_{GS} = 0V, I_{SD} = 4A$			-	-	1.4	V
*SD	Reverse	Recovery Time		$V_{GS} = 0V, I_{SD} = 5A$		-	300	-	ns	
• SD rr		se Recovery Charge		$dI_F/dt = 100A/\mu s$ (Note 4)		-	1.8	-	μC	

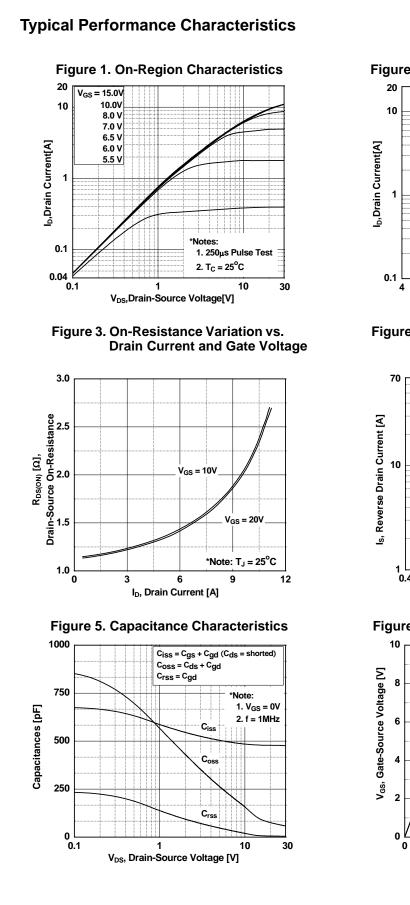
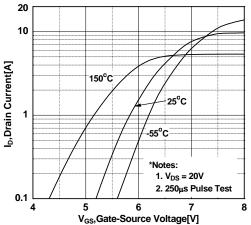
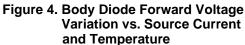


Figure 2. Transfer Characteristics





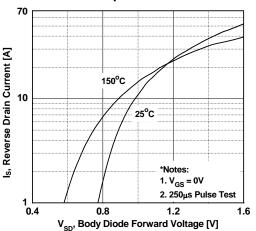
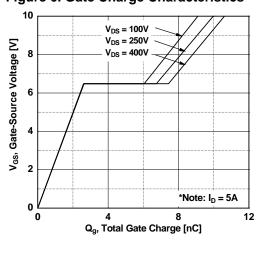
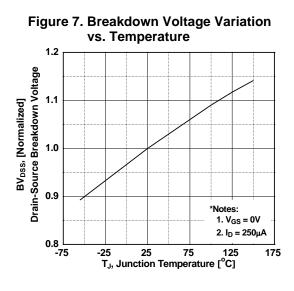


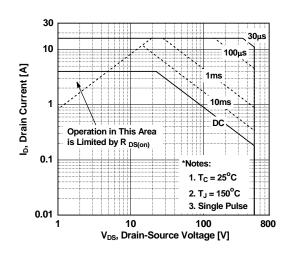
Figure 6. Gate Charge Characteristics



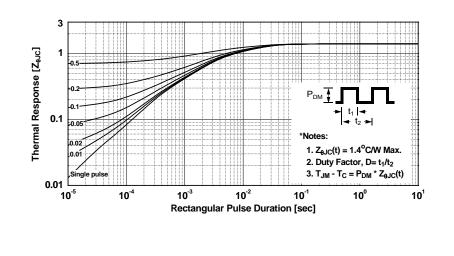














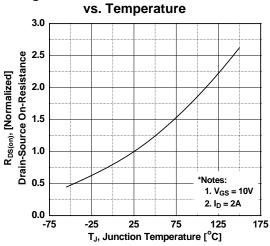
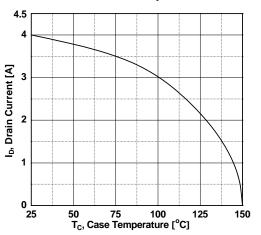
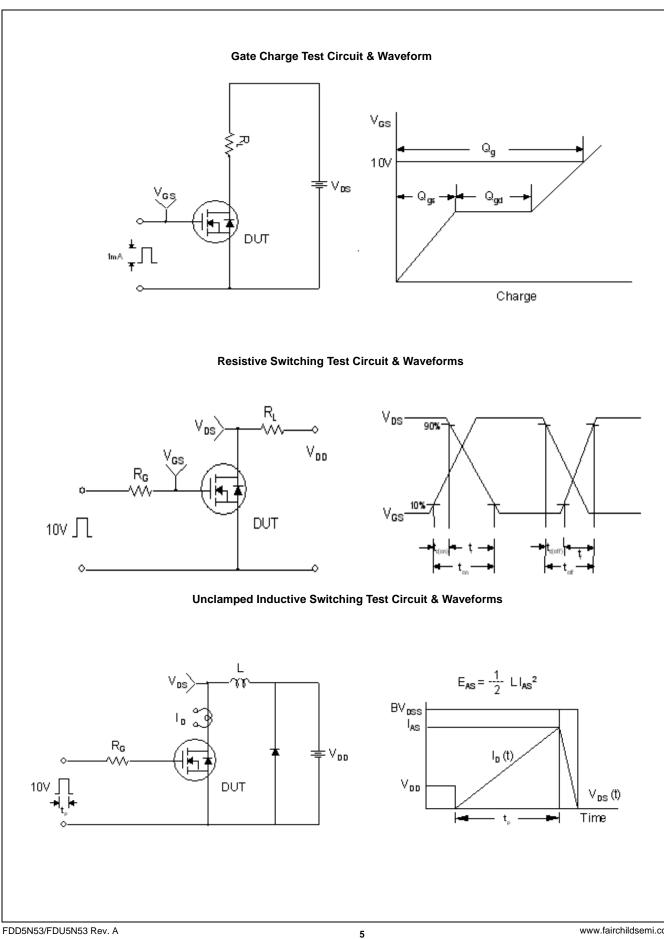


Figure 8. On-Resistance Variation

Figure 10. Maximum Drain Current vs. Case Temperature

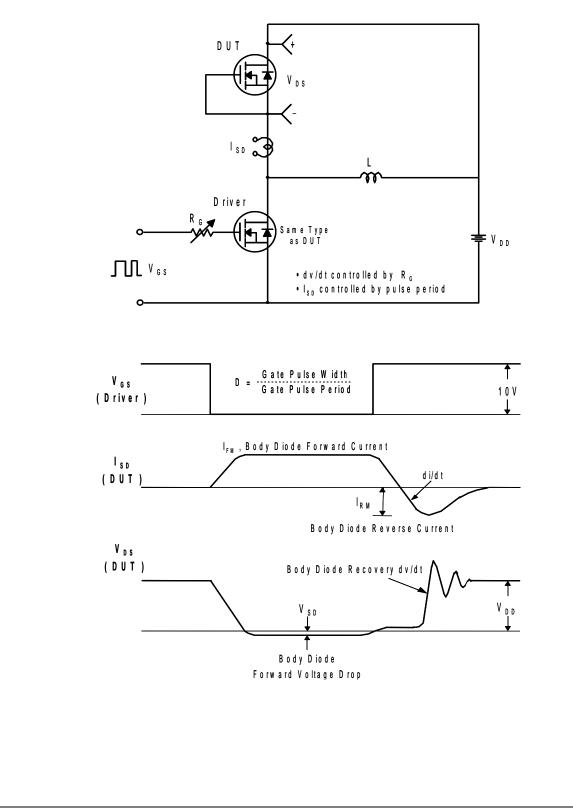


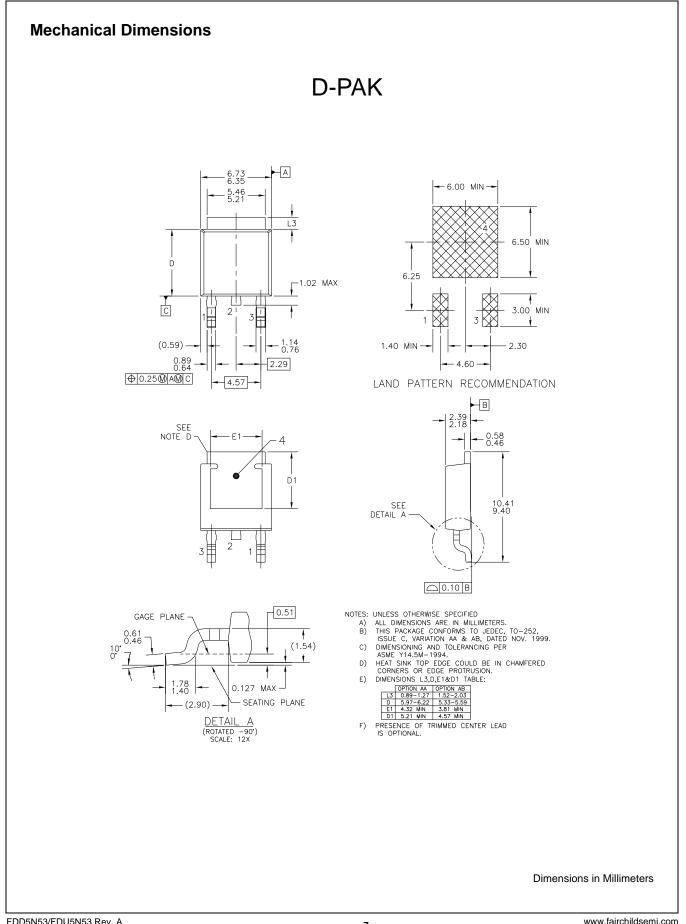
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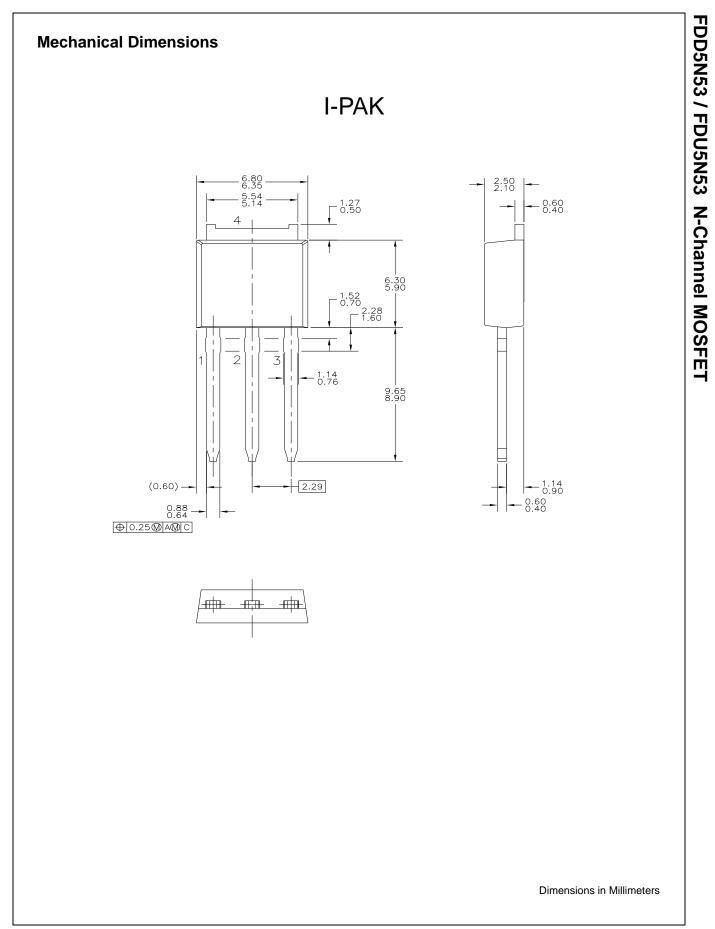


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Peak Diode Recovery dv/dt Test Circuit & Waveforms









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Rev. 137